Form PTO 1449 (Modified)				ATTY DOCKET NO.		SERIAL NO.			
			255291US53PCT	10/502,045					
LIST OF	BEEED	RENCES CITED BY AP	PLICANT	APPLICANT					
LISTOF	KEFER	LENCES CITED BY AF	PLICANT	Atsushi KUDO, et al.					
				FILING DATE		GROUP			
				January 10, 2005	1797				
U.S. PATENT DOCUMENTS									
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS			
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		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO			
	AO	JP 2003-117322	4/22/2003	Japan (with English Abstract and unedited computer-generated English translation)		x			
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
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